

TEST REPORT

Applicant: Fibocom Wireless Inc
Address: 1101, Tower A, Building 6, Shenzhen International Innovation Valley, Dashi 1st Rd, Nanshan, Shenzhen, China
Equipment Type: LTE Module
Model Name: SC126-NA
Brand Name: FIBOCOM
FCC ID: ZMOSC126NA
Test Standard: 47 CFR Part 15 Subpart B
Sample Arrival Date: Nov. 11, 2022
Test Date: Nov. 28, 2022 - Dec. 09, 2022
Date of Issue: Jan. 18, 2023

ISSUED BY:

Shenzhen BALUN Technology Co., Ltd.

Tested by: Sijie Zheng

Checked by: Xia Long

Approved by: Wei Yanquan
(Chief Engineer)

Sijie Zheng

Xia Long

Wei Yanquan

Revision History

Version	Issue Date	Revisions Content
<u>Rev. 01</u>	<u>Jan. 18, 2023</u>	<u>Initial Issue</u>

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1 GENERAL INFORMATION

1.1 Test Laboratory

Name	Shenzhen BALUN Technology Co., Ltd.
Address	Block B, 1/F, Baisha Science and Technology Park, Shahe Xi Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China
Phone Number	+86 755 6685 0100

1.2 Test Location

Name	Shenzhen BALUN Technology Co., Ltd.
Location	<input checked="" type="checkbox"/> Block B, 1/F, Baisha Science and Technology Park, Shahe Xi Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China
	<input type="checkbox"/> 1/F, Building B, Ganghongji High-tech Intelligent Industrial Park, No. 1008, Songbai Road, Yangguang Community, Xili Sub-district, Nanshan District, Shenzhen, Guangdong Province, P. R. China
Accreditation Certificate	The laboratory is a testing organization accredited by FCC as a accredited testing laboratory. The designation number is CN1196. The laboratory has been listed by Industry Canada to perform electromagnetic emission measurements. The recognition numbers of test site are 11524A-1.

2 PRODUCT INFORMATION

2.1 Applicant Information

Applicant	Fibocom Wireless Inc
Address	1101, Tower A, Building 6, Shenzhen International Innovation Valley, Dashi 1st Rd, Nanshan, Shenzhen, China

2.2 Manufacturer Information

Manufacturer	Fibocom Wireless Inc
Address	1101, Tower A, Building 6, Shenzhen International Innovation Valley, Dashi 1st Rd, Nanshan, Shenzhen, China

2.3 Factory Information

Factory	N/A
Address	N/A

2.4 General Description for Equipment under Test (EUT)

EUT Name	LTE Module
Model Name Under Test	SC126-NA
Series Model Name	N/A
Description of Model name differentiation	N/A
Hardware Version	V1.1
Software Version	N/A
Dimensions (Approx.)	N/A
Weight (Approx.)	N/A

2.5 Ancillary Equipment

Note: Not applicable.

2.6 Technical Information

Network and Wireless connectivity	4G Network FDD LTE Band 2/4/5/7/12/13/17/25/26/66/71 TDD LTE Band 41 Bluetooth (BR+EDR+BLE) 2.4G WIFI 802.11b, 802.11g, 802.11n(HT20/40) 5G WIFI 802.11a, 802.11n(HT20/40), 802.11ac(VHT20/40/80) U-NII-1/2A/2C/3, GPS, GLONASS, BeiDou
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The requirement for the following technical information of the EUT was tested in this report:

The Highest Speed of Processor	N/A
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3 SUMMARY OF TEST RESULTS

3.1 Test Standards

No.	Identity	Document Title
1	47 CFR Part 15 Subpart B	Unintentional Radiators
2	ANSI C63.4-2014	American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9 kHz to 40 GHz

3.2 Verdict

No.	Description	FCC Rule	Test Verdict	Result
1	Radiated Emission	15.109	Pass	Annex A .1
2	Conducted Emission, AC Ports	15.107	Pass	Annex A .2

3.3 Test Uncertainty

The following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of $k=2$.

Measurement	Value
Conducted emissions (9 kHz-30 MHz)	3.22 dB
Radiated emissions (30 MHz-1 GHz)-10m	4.80 dB
Radiated emissions (30 MHz-1 GHz)-3m	4.76 dB
Radiated emissions (1 GHz-18 GHz)-3m	4.88 dB

4 GENERAL TEST CONFIGURATIONS

4.1 Test Environments, Test Date and Test Engineer

Test items	Voltage	Temperature	Relative Humidity	Ambient Pressure	Test Date	Test Engineer
Radiated Emission	DC 3.87V	25°C	55%	101kPa	Nov. 28, 2022	Gu Shuaizhen
					Dec. 09, 2022	Tian Hengzhao
Conducted Emission	DC 3.87V	25°C	55%		Dec. 01, 2022	Gu Shuaizhen

4.2 Test Equipment List

Radiated Emission Test For Frequency Below 1 GHz (3m-966#2)						
Description	Manufacturer	Model	Serial No.	Cal. Date	Cal. Due	Use
EMI Receiver	Agilent	N9038A	MY55330120	2022.09.09	2023.09.08	<input checked="" type="checkbox"/>
Amplifier (30-1GHz)	COM-MV	ZT30-1000M	B2017119081	2022.09.09	2023.09.08	<input checked="" type="checkbox"/>
Test Antenna- Bi-Log	SCHWARZBECK	VULB 9168	9168-00867	2022.04.12	2025.04.11	<input checked="" type="checkbox"/>
Anechoic Chamber	YiHeng	9m*6m*6m	966#2	2021.08.19	2024.08.18	<input checked="" type="checkbox"/>
Description	Manufacturer	Name		Version		Use
Test Software	BALUN	BL410-E		V19.918		<input checked="" type="checkbox"/>

Radiated Emission Test For Frequency Above 1 GHz (3m-966#2)						
Description	Manufacturer	Model	Serial No.	Cal. Date	Cal. Due	Use
EMI Receiver	Agilent	N9038A	MY55330120	2022.09.09	2023.09.08	<input checked="" type="checkbox"/>
Amplifier (1-12GHz)	Advanced Microwave	WLA652A	1740103	2022.09.09	2023.09.08	<input checked="" type="checkbox"/>
Amplifier (0.8-21GHz)	Mini-Circuits	ZVA-213-S+	225321316	2022.09.09	2023.09.08	<input checked="" type="checkbox"/>
Amplifier (18-40GHz)	COM-MV	KA_LNA18- 40G-01	18050001	2022.09.09	2023.09.08	<input checked="" type="checkbox"/>
Test Antenna- Horn	SCHWARZBECK	BBHA 9120D	1917	2022.06.09	2025.06.08	<input checked="" type="checkbox"/>
Anechoic Chamber	YiHeng	9m*6m*6m	142	2021.08.19	2024.08.18	<input checked="" type="checkbox"/>
Description	Manufacturer	Name		Version		Use
Test Software	BALUN	BL410-E		V19.918		<input checked="" type="checkbox"/>

Conducted disturbance Test						
Description	Manufacturer	Model	Serial No.	Cal. Date	Cal. Due	Use
EMI Receiver	KEYSIGHT	N9010B	MY57110309	2022.09.09	2023.09.08	<input checked="" type="checkbox"/>
LISN	SCHWARZBECK	NSLK 8127	8127-687	2022.06.01	2023.05.31	<input checked="" type="checkbox"/>
Shielded Room	YiHeng Electronic Co., Ltd	3.5m*3.1m*2. 8m	112	2022.02.19	2025.02.18	<input checked="" type="checkbox"/>
Description	Manufacturer	Name		Version		Use
Test Software	BALUN	BL410-E		V19.918		<input checked="" type="checkbox"/>

4.3 Test Enclosure list

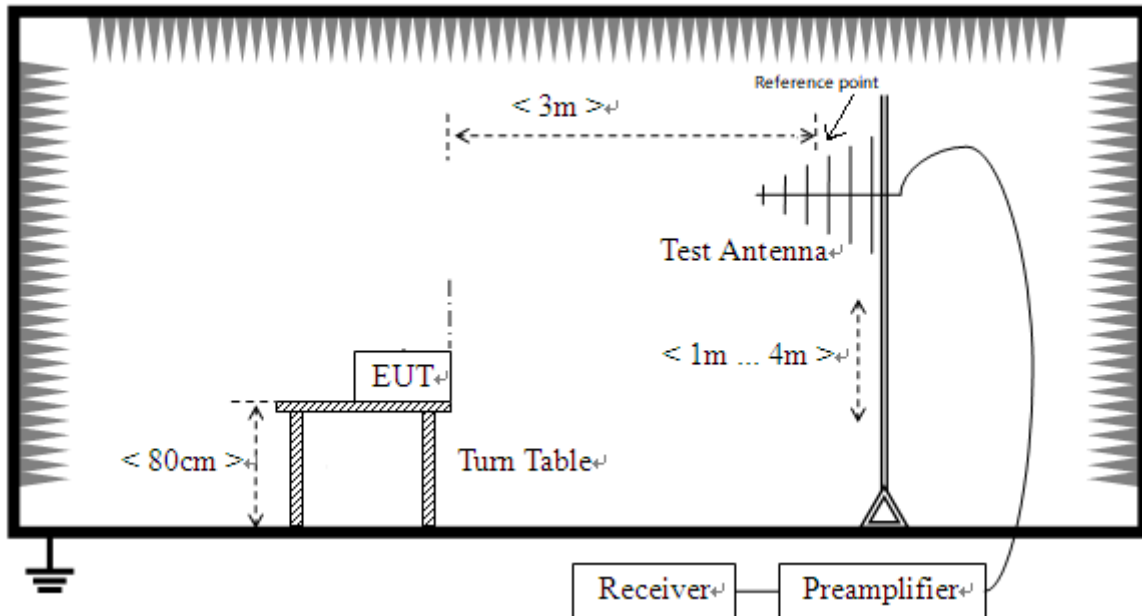
Description	Manufacturer	Model	Serial No.	Length	Description	Use
Wireless Communications Test Set	R&S	CMW500	102318	N/A	Cal. Due 2023.05.18	<input checked="" type="checkbox"/>
DC Power Supply	ITECH	IT6863A	6000140 1068721 0000	N/A	N/A	<input checked="" type="checkbox"/>

4.4 Test Configurations

Test Configurations (TC) No.	Description
TC01	<u>The FDD LTE Band 5 RX Test Mode</u> LTE Band 5 RX + EUT + DC Power Supply
TC02	<u>The FDD LTE Band 12 RX Test Mode</u> LTE Band 12 RX + EUT + DC Power Supply
TC03	<u>The FDD LTE Band 13 RX Test Mode</u> LTE Band 13 RX + EUT + DC Power Supply
TC04	<u>The FDD LTE Band 17 RX Test Mode</u> LTE Band 17 RX + EUT + DC Power Supply
TC05	<u>The FDD LTE Band 26 RX Test Mode</u> LTE Band 26 RX + EUT + DC Power Supply
TC06	<u>The FDD LTE Band 71 RX Test Mode</u> LTE Band 71 RX + EUT + DC Power Supply
TC07	<u>The Charge Test Mode</u> EUT + DC Power Supply

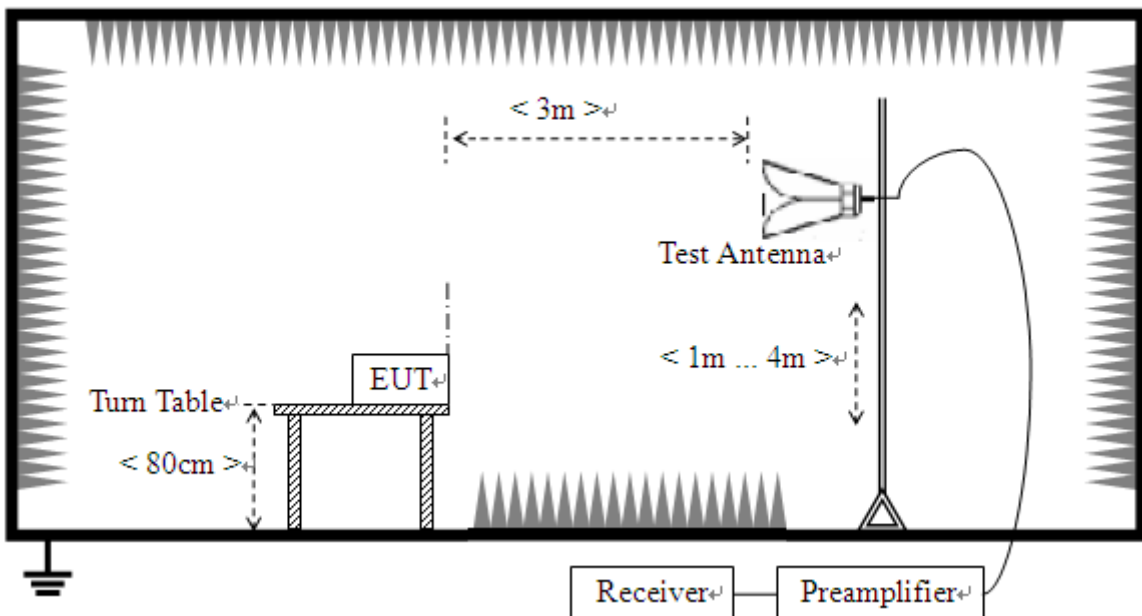
4.5 Test Setups

Test Setup 1



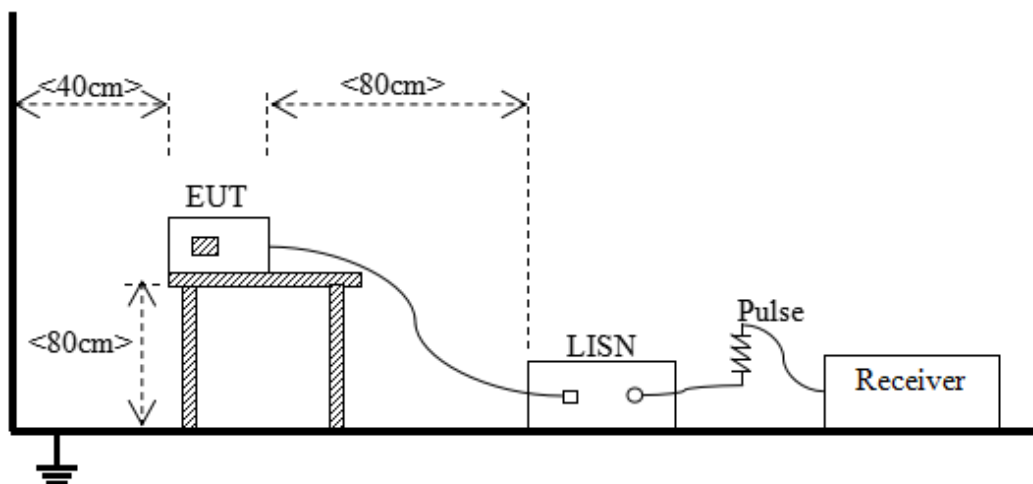
(For Radiated Emission Test (30 MHz-1 GHz))

Test Setup 2



(For Radiated Emission Test (above 1 GHz))

Test Setup 3



(For Conducted Emission, AC Ports Test)

4.6 Test Conditions

Test Case	Test Conditions	
Radiated Emission	Test Setup	Test Setup 1&2
	Test Configuration	TC01~TC07 ^{Note}
Conducted Emission, AC Ports	Test Setup	Test Setup 3
	Test Configuration	TC01~TC07 ^{Note}

Note: Based on client request, all normal using modes of the normal function were tested but only the worst test data of the worst mode is reported by this report. The Charge Test Mode is the worst mode in this report.

5 TEST ITEMS

5.1 Emission Tests

5.1.1 Radiated Emission

5.1.1.1 Limit

Frequency range (MHz)	Class B (at 3 m)		Class B (at 10 m)	Class A (at 10 m)	
	Field Strength ($\mu\text{V/m}$)	Field Strength ($\text{dB}\mu\text{V/m}$)	Field Strength ($\text{dB}\mu\text{V/m}$)	Field Strength ($\mu\text{V/m}$)	Field Strength ($\text{dB}\mu\text{V/m}$)
30 - 88	100	40	30	90	39
88 - 216	150	43.5	33.5	150	43.5
216 - 960	200	46	36	210	46.4
Above 960	500	54	44	300	49.5

NOTE:

- 1) Field Strength ($\text{dB}\mu\text{V/m}$) = $20 \cdot \log$ [Field Strength ($\mu\text{V/m}$)].
- 2) In the emission tables above, the tighter limit applies at the band edges.
- 3) The limits using ANSI C63.4.

5.1.1.2 Test Setup

Refer to 4.5 section (test setup 1 to test setup 2) for radiated emission test, the photo of test setup please refer to ANNEX B.

5.1.1.3 Test Procedure

The test employing the methods of measurement described in the publication referenced in Section 3(b) (ANSI C63.4);

All Spurious Emission tests were performed in X, Y, Z axis direction. And only the worst axis test condition was recorded in this test report.

An initial pre-scan was performed in the chamber using the EMI Receiver in peak detection mode. Quasi-peak measurements were conducted based on the peak sweep graph. The EUT was measured by Bi-Log antenna with 2 orthogonal polarities.

The measurement frequency range is from 30 MHz to the 5th harmonic of the maximum frequency of the EUT internal source. The Turn Table is actuated to turn from 0° to 360° , and both horizontal and vertical polarizations of the Test Antenna are used to find the maximum radiated power. Mid channels on all channel bandwidth verified. Only the worst RB size/offset presented.

Use the following spectrum analyzer settings:

Span = wide enough to fully capture the emission being measured

RBW = 1 MHz for $f \geq 1$ GHz, 100 kHz for $f < 1$ GHz

VBW \geq RBW

Sweep = auto

Detector function = peak for $f < 1$ GHz, peak & RMS Average for $f \geq 1$ GHz

Trace = max hold

5.1.1.4 Test Result

Please refer to ANNEX A.1.

NOTE:

1. Results (dB μ V/m) = Reading (dB μ V/m) + Factor (dB/m)

The reading level is calculated by software which is not shown in the sheet

2. Factor (dB/m) = Antenna Factor (dB/m) + Cable Factor (dB) – Amplifier Gain (dB)

3. Over limit = Results – Limit.

5.1.2 Conducted Emission

5.1.2.1 Test Limit

Frequency range (MHz)	Class A	
	Quasi-peak (dB μ V)	Average (dB μ V)
0.15 - 0.50	79	66
0.50 - 30	73	60

Frequency range (MHz)	Class B	
	Quasi-peak (dB μ V)	Average (dB μ V)
0.15 - 0.50	66 to 56	56 to 46
0.50 - 5	56	46
5 - 30	60	50

NOTE:

- 1) The lower limit shall apply at the band edges.
- 2) The limit decreases linearly with the logarithm of the frequency in the range 0.15 - 0.50 MHz.
- 3) The limit using ANSI C63.4.

5.1.2.2 Test Setup

Refer to 4.5 section test (test setup 3) for conducted emission, the photo of test setup please refer to ANNEX B.

5.1.2.3 Test Procedure

The test employing the methods of measurement described in the publication referenced in Section 3(b) (ANSI C63.4);

The EUT is connected to the power mains through a LISN which provides 50 Ω /50 μ H of coupling impedance for the measuring instrument. The test frequency range is from 150 kHz to 30 MHz. The maximum conducted interference is searched using Peak (PK), Quasi-peak (QP) and Average (AV) detectors; the emission levels that are more than the AV and QP limits, and that have narrow margins from the AV and QP limits will be re-measured with AV and QP detectors. Tests for both L phase and N phase lines of the power mains connected to the EUT are performed.

Devices subject to Part 15 must be tested for all available U.S. voltages and frequencies (such as a nominal 120 VAC, 50/60 Hz and 240 VAC, 50/60 Hz) for which the device is capable of operation. A device rated for 50/60 Hz operation need not be tested at both frequencies provided the radiated and line conducted emissions are the same at both frequencies.

Use the following spectrum analyzer settings:

RBW = 9 kHz

VBW \geq RBW

Sweep = 10ms

Detector function =peak & Average

Trace = max hold

5.1.2.4 Test Result

Please refer to ANNEX A.2.

NOTE:

1. Results (dB μ V) = Reading (dB μ V) + Factor (dB)

The reading level is calculated by software which is not shown in the sheet

2. Factor = Insertion loss + Cable loss

3. Over limit = Results – Limit.

ANNEX A TEST RESULTS

A.1 Radiated Emission

Note 1: The symbol of "--" in the table which means not application.

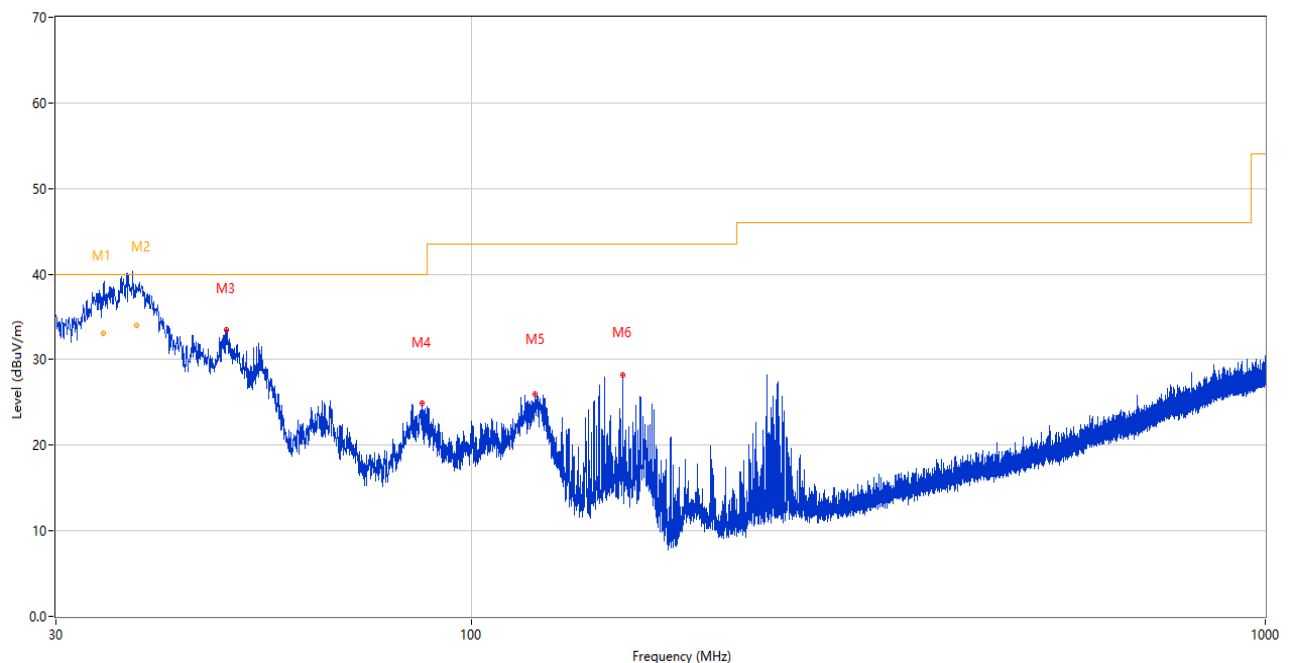
Note 2: For the test data above 1 GHz, according the ANSI C63.4-2014, where limits are specified for both average and peak (or quasi-peak) detector functions, if the peak (or quasi-peak) measured value complies with the average limit, it is unnecessary to perform an average measurement.

Note 3: The Radiated Emission from 18G-40G is noise only, do not show on the report.

Test Data and Plots

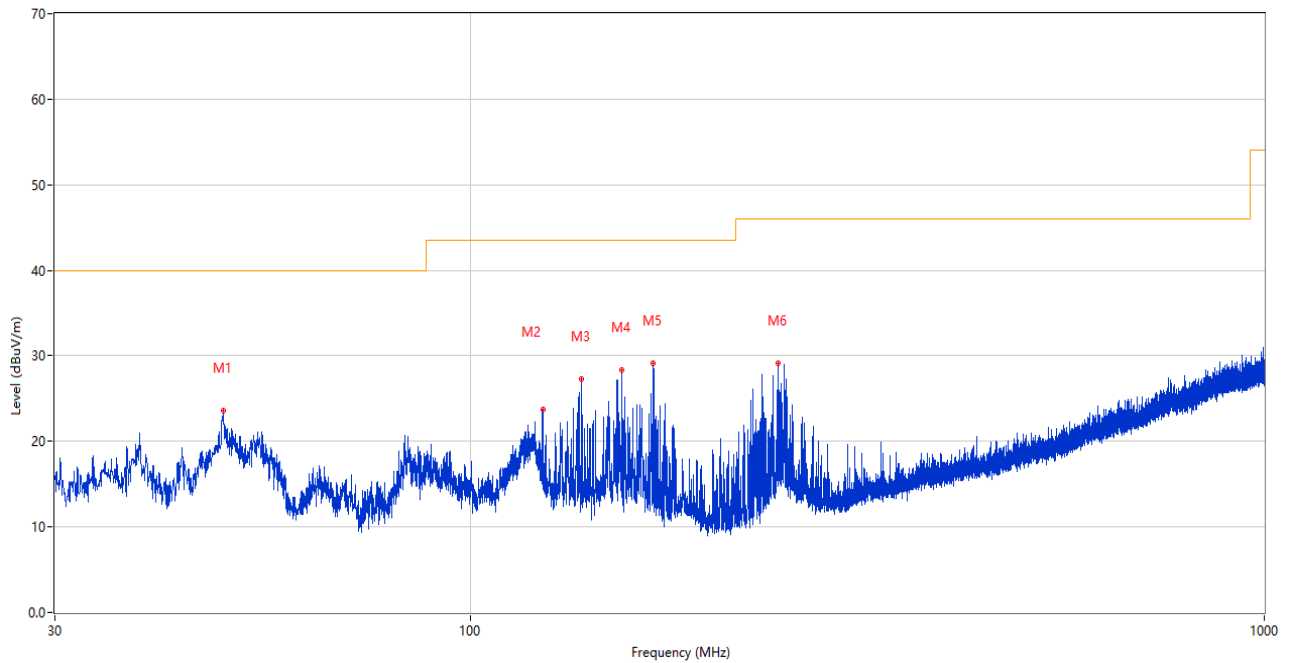
The Charge Test Mode

A.1.1 Test Antenna Vertical, 30 MHz – 1 GHz



No.	Frequency (MHz)	Results (dBuV/m)	Factor (dB)	Limit (dBuV/m)	Margin (dB)	Detector	Table (Degree)	Height (cm)	Antenna	Verdict
1	34.446	38.88	-28.61	40.0	1.12	Peak	276.00	101	Vertical	N/A
1*	34.446*	33.03	-28.61	40.0	6.97	QP	276.00	101	Vertical	Pass
2	37.894	40.99	-27.43	40.0	-0.99	Peak	55.00	101	Vertical	N/A
2*	37.894*	34.00	-27.43	40.0	6.00	QP	55.00	101	Vertical	Pass
3	49.157	33.42	-25.44	40.0	6.58	Peak	335.00	100	Vertical	Pass
4	86.648	24.88	-29.50	40.0	15.12	Peak	352.00	100	Vertical	Pass
5	120.307	25.91	-28.37	43.5	17.59	Peak	233.00	100	Vertical	Pass
6	155.227	28.20	-29.84	43.5	15.30	Peak	9.00	100	Vertical	Pass

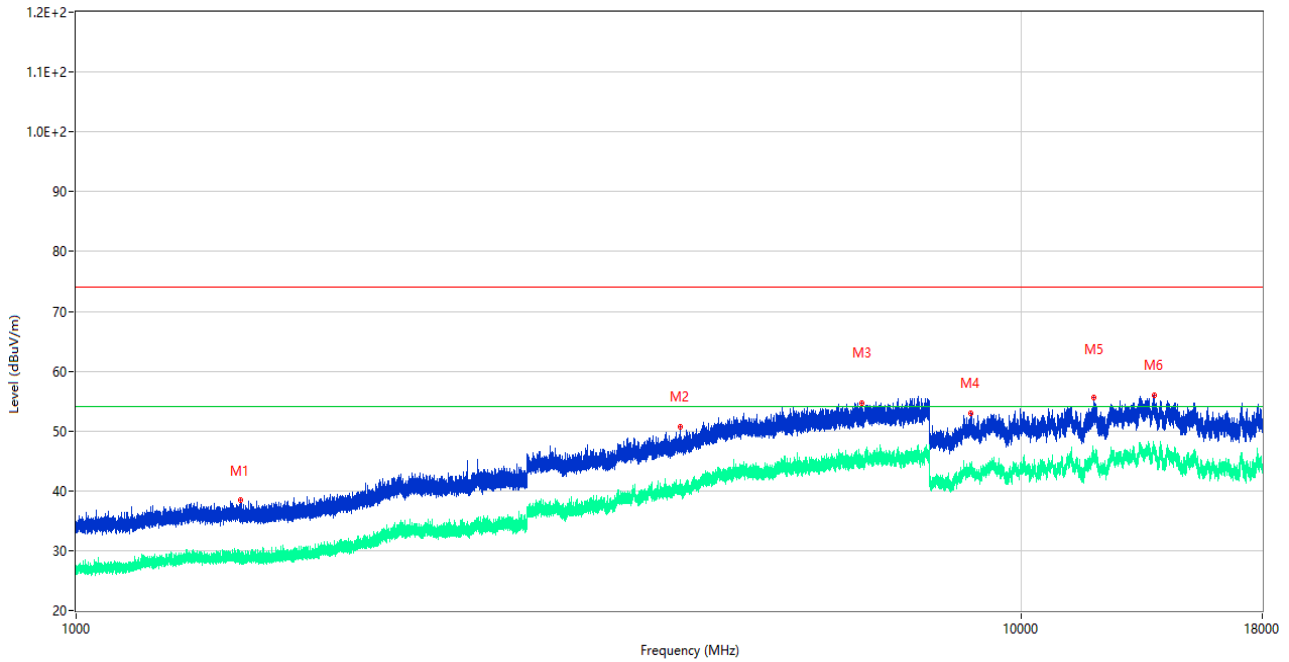
A.1.2 Test Antenna Horizontal, 30 MHz – 1 GHz



No.	Frequency (MHz)	Results (dBuV/m)	Factor (dB)	Limit (dBuV/m)	Margin (dB)	Detector	Table (Degree)	Height (cm)	Antenna	Verdict
1	48.867	23.64	-25.37	40.0	16.36	Peak	0.00	200	Horizontal	Pass
2	123.411	23.66	-29.03	43.5	19.84	Peak	286.00	200	Horizontal	Pass
3	138.155	27.34	-30.20	43.5	16.16	Peak	135.00	200	Horizontal	Pass
4	155.324	28.39	-29.83	43.5	15.11	Peak	118.00	200	Horizontal	Pass
5	170.165	29.17	-29.17	43.5	14.33	Peak	142.00	200	Horizontal	Pass
6	244.370	29.14	-25.08	46.0	16.86	Peak	74.00	100	Horizontal	Pass

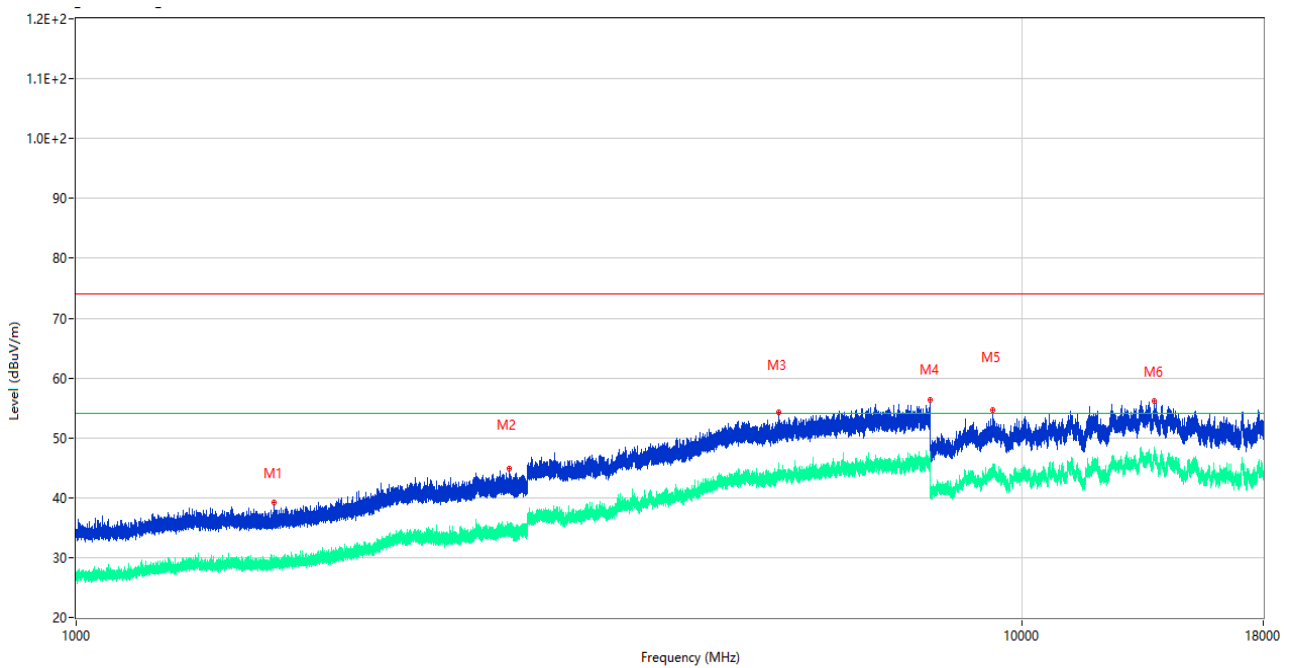
Test Data and Plots (Above 1 GHz)

A.1.3 Test Antenna Vertical, 1 GHz – 18 GHz



No.	Frequency (MHz)	Results (dBuV/m)	Factor (dB)	Limit (dBuV/m)	Margin (dB)	Detector	Table (Degree)	Height (cm)	Antenna	Verdict
1	1494.100	38.43	-16.76	74.0	35.57	Peak	122.00	100	Vertical	Pass
1**	1494.100	29.31	-16.76	54.0	24.69	AV	122.00	100	Vertical	Pass
2	4361.250	50.77	-1.27	74.0	23.23	Peak	263.00	100	Vertical	Pass
2**	4361.250	40.41	-1.27	54.0	13.59	AV	263.00	100	Vertical	Pass
3	6779.250	54.71	1.08	74.0	19.29	Peak	275.00	100	Vertical	Pass
3**	6779.250	44.95	1.08	54.0	9.05	AV	275.00	100	Vertical	Pass
4	8856.001	53.03	1.41	74.0	20.97	Peak	345.00	100	Vertical	Pass
4**	8856.001	44.30	1.41	54.0	9.70	AV	345.00	100	Vertical	Pass
5	11950.000	55.64	2.64	74.0	18.36	Peak	215.00	100	Vertical	Pass
5**	11950.000	45.26	2.64	54.0	8.74	AV	215.00	100	Vertical	Pass
6	13836.000	55.96	5.35	74.0	18.04	Peak	197.00	100	Vertical	Pass
6**	13836.000	46.72	5.35	54.0	7.28	AV	197.00	100	Vertical	Pass

A.1.4 Test Antenna Horizontal, 1 GHz – 18 GHz



No.	Frequency (MHz)	Results (dBuV/m)	Factor (dB)	Limit (dBuV/m)	Margin (dB)	Detector	Table (Degree)	Height (cm)	Antenna	Verdict
1	1620.600	39.16	-16.78	74.0	34.84	Peak	186.00	100	Horizontal	Pass
1**	1620.600	28.75	-16.78	54.0	25.25	AV	186.00	100	Horizontal	Pass
2	2871.200	44.86	-8.92	74.0	29.14	Peak	88.00	100	Horizontal	Pass
2**	2871.200	35.14	-8.92	54.0	18.86	AV	88.00	100	Horizontal	Pass
3	5527.000	54.29	0.69	74.0	19.71	Peak	351.00	100	Horizontal	Pass
3**	5527.000	44.27	0.69	54.0	9.73	AV	351.00	100	Horizontal	Pass
4	7993.250	56.38	2.51	74.0	17.62	Peak	275.00	100	Horizontal	Pass
4**	7993.250	46.52	2.51	54.0	7.48	AV	275.00	100	Horizontal	Pass
5	9325.500	54.59	2.17	74.0	19.41	Peak	219.00	100	Horizontal	Pass
5**	9325.500	44.44	2.17	54.0	9.56	AV	219.00	100	Horizontal	Pass
6	13792.500	56.11	5.47	74.0	17.89	Peak	239.00	100	Horizontal	Pass
6**	13792.500	46.32	5.47	54.0	7.68	AV	239.00	100	Horizontal	Pass

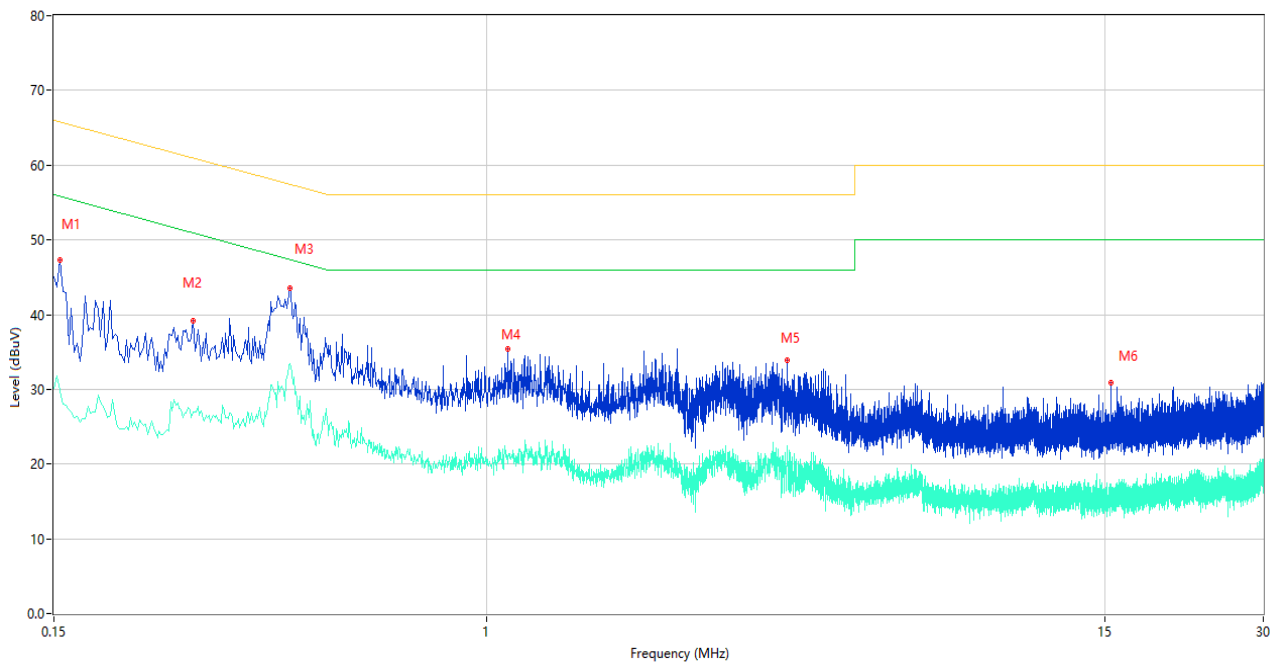
A.2 Conducted Emission

Note: Devices subject to Part 15 must be tested for all available U.S. voltages and frequencies (such as a nominal 120 VAC, 50/60 Hz and 240 VAC, 50/60 Hz) for which the device is capable of operation. So, The configuration 120 VAC, 60 Hz and 240 VAC, 50 Hz were tested respectively, but only the worst configuration (120 VAC, 60 Hz) shown here.

Test Data and Plots

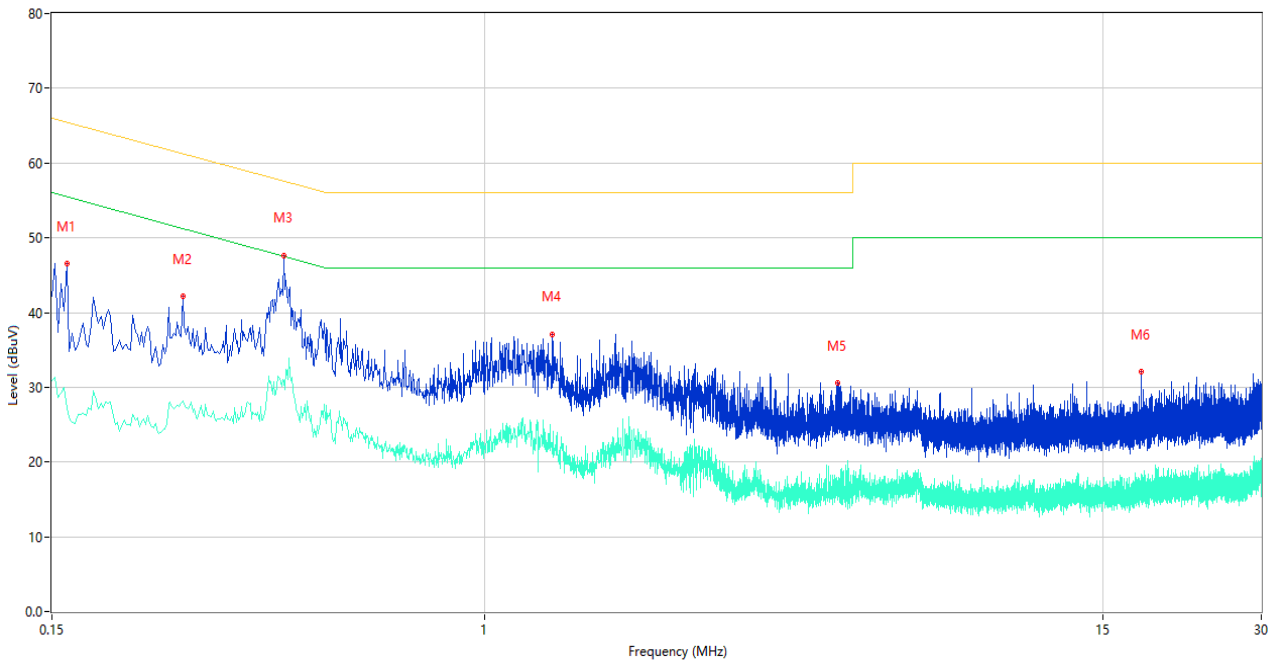
The Charge Test Mode

A.2.1 Positive Phase



No.	Frequency (MHz)	Results (dBUV)	Factor (dB)	Limit (dBUV)	Margin (dB)	Detector	Line	Verdict
1	0.154	47.37	10.18	65.78	18.41	Peak	Positive	Pass
1**	0.154	29.85	10.18	55.78	25.93	AV	Positive	Pass
2	0.276	39.23	10.06	60.94	21.71	Peak	Positive	Pass
2**	0.276	27.01	10.06	50.94	23.93	AV	Positive	Pass
3	0.422	43.47	10.58	57.41	13.94	Peak	Positive	Pass
3**	0.422	33.44	10.58	47.41	13.97	AV	Positive	Pass
4	1.098	35.34	10.35	56.00	20.66	Peak	Positive	Pass
4**	1.098	21.08	10.35	46.00	24.92	AV	Positive	Pass
5	3.728	33.83	10.59	56.00	22.17	Peak	Positive	Pass
5**	3.728	22.24	10.59	46.00	23.76	AV	Positive	Pass
6	15.384	30.86	10.25	60.00	29.14	Peak	Positive	Pass
6**	15.384	17.03	10.25	50.00	32.97	AV	Positive	Pass

A.2.2 Negative Phase



No.	Frequency (MHz)	Results (dBuV)	Factor (dB)	Limit (dBuV)	Margin (dB)	Detector	Line	Verdict
1	0.160	46.60	10.17	65.46	18.86	Peak	Negative	Pass
1**	0.160	27.27	10.17	55.46	28.19	AV	Negative	Pass
2	0.266	42.12	10.07	61.24	19.12	Peak	Negative	Pass
2**	0.266	28.24	10.07	51.24	23.00	AV	Negative	Pass
3	0.414	47.67	10.59	57.57	9.90	Peak	Negative	Pass
3**	0.414	30.89	10.59	47.57	16.68	AV	Negative	Pass
4	1.344	37.13	10.34	56.00	18.87	Peak	Negative	Pass
4**	1.344	21.04	10.34	46.00	24.96	AV	Negative	Pass
5	4.694	30.53	10.31	56.00	25.47	Peak	Negative	Pass
5**	4.694	16.33	10.31	46.00	29.67	AV	Negative	Pass
6	17.702	32.03	10.24	60.00	27.97	Peak	Negative	Pass
6**	17.702	16.86	10.24	50.00	33.14	AV	Negative	Pass

ANNEX B TEST SETUP PHOTOS

Please refer the document “BL-SZ22B0531-AE-1.PDF”.

ANNEX C EUT EXTERNAL PHOTOS

Please refer the document “BL-SZ22B0531-AW.PDF”.

ANNEX D EUT INTERNAL PHOTOS

Please refer the document “BL-SZ22B0531-AI.PDF”.

Statement

1. The laboratory guarantees the scientificity, accuracy and impartiality of the test, and is responsible for all the information in the report, except the information provided by the customer. The customer is responsible for the impact of the information provided on the validity of the results.
2. The report without China inspection body and laboratory Mandatory Approval (CMA) mark has no effect of proving to the society.
3. For the report with CNAS mark or A2LA mark, the items marked with "☆" are not within the accredited scope.
4. This report is invalid if it is altered, without the signature of the testing and approval personnel, or without the "inspection and testing dedicated stamp" or test report stamp.
5. The test data and results are only valid for the tested samples provided by the customer.
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--END OF REPORT--